

ON Semiconductor®

FGA15N120ANTDTU 1200 V, 15 A NPT Trench IGBT

Features

- · NPT Trench Technology, Positive temperature coefficient
- Low Saturation Voltage: V_{CE(sat)}, typ = 1.9 V
 I_C = 15 A and T_C = 25°C
- Low Switching Loss: $E_{off, typ} = 0.6 \text{ mJ}$ @ $I_C = 15 \text{ A}$ and $T_C = 25 ^{\circ}\text{C}$
- Extremely Enhanced Avalanche Capability

Description

Using ON Semiconductor's proprietary trench design and advanced NPT technology, the 1200V NPT IGBT offers superior conduction and switching performances, high avalanche ruggedness and easy parallel operation.

This device is well suited for the resonant or soft switching application such as induction heating, microwave oven.



GCE

Absolute Maximum Ratings

TO-3P

Symbol	Description		Ratings	Unit
V _{CES}	Collector-Emitter Voltage		1200	V
V _{GES}	Gate-Emitter Voltage		± 20	V
I _C	Collector Current	@ T _C = 25°C	30	A
	Collector Current	@ T _C = 100°C	15	А
I _{CM}	Pulsed Collector Current (Note 1)		45	A
1	Diode Continuous Forward Current	@ T _C = 25°C	= 25°C 30	
l _F	Diode Continuous Forward Current	@ T _C = 100°C	15	A
I _{FM}	Diode Maximum Forward Current		45	Α
_	Maximum Power Dissipation	@ T _C = 25°C	186	W
P_D	Maximum Power Dissipation	@ T _C = 100°C	74	W
TJ	Operating Junction Temperature		-55 to +150	°C
T _{stg}	Storage Temperature Range		-55 to +150	°C
TL 4	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds	EL	300	°C

Thermal Characteristics

Symbol	Symbol Parameter		Max.	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case for IGBT		0.67	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case for Diode		2.88	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		40	°C/W

Notes:

(1) Repetitive rating: Pulse width limited by max. junction temperature

Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	el Size Tape Width		
FGA15N120ANTDTU-F109	FGA15N120ANTDTU	TO-3P	Tube	N/A	N/A	30	

Electrical Characteristics of the IGBT $T_C = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	eteristics					
I _{CES}	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0 V$		-/	3	mA
I _{GES}	G-E Leakage Current	V _{GE} = V _{GES} , V _{CE} = 0 V	= 1	44	± 250	nA
On Charac	eteristics					
V _{GE(th)}	G-E Threshold Voltage	$I_C = 15 \text{ mA}, V_{CE} = V_{GE}$	4.5	6.5	8.5	V
V _{CE(sat)}	Collector to Emitter	I _C = 15 A, V _{GE} = 15 V		1.9	2.4	V
	Saturation Voltage	I _C = 15 A, V _{GE} = 15 V, T _C = 125°C	4	2.2		٧
		I _C = 30 A, V _{GE} = 15 V	-	2.3		V
Dynamic C	Characteristics			1		
C _{ies}	Input Capacitance	$V_{CE} = 30 \text{ V}, V_{GE} = 0 \text{ V},$		2650		pF
C _{oes}	Output Capacitance	f = 1 MHz	-	143	-	pF
C _{res}	Reverse Transfer Capacitance	A A STATE OF THE S		96		pF
Switching	Characteristics		M			
t _{d(on)}	Turn-On Delay Time	$V_{CC} = 600 \text{ V}, I_{C} = 15 \text{ A},$	7	15	- 1	ns
t _r	Rise Time	$R_G = 10 \Omega$, $V_{GE} = 15 V$, Inductive Load, $T_C = 25$ °C	7	20		ns
$t_{d(off)}$	Turn-Off Delay Time	madelive Zoda, 16=20 o	-	160	1	ns
t_f	Fall Time	4		100	180	ns
E _{on}	Turn-On Switching Loss			3	4.5	mJ
E _{off}	Turn-Off Switching Loss			0.6	0.9	mJ
E _{ts}	Total Switching Loss			3.6	5.4	mJ
t _{d(on)}	Turn-On Delay Time	$V_{CC} = 600 \text{ V}, I_{C} = 15 \text{ A},$		15		ns
t _r	Rise Time	$R_G = 10 \Omega$, $V_{GE} = 15 V$, Inductive Load, $T_C = 125^{\circ}C$		20	- 1	ns
t _{d(off)}	Turn-Off Delay Time	11000110 2500, 1C = 120 0		170		ns
t _f	Fall Time			150	-	ns
E _{on}	Turn-On Switching Loss	ELEC.	-R	3.2	4.8	mJ
E _{off}	Turn-Off Switching Loss			0.8	1.2	mJ
E _{ts}	Total Switching Loss			4.0	6.0	mJ
Qg	Total Gate Charge	$V_{CE} = 600 \text{ V}, I_{C} = 15 \text{ A},$		120	180	nC
Q _{ge}	Gate-Emitter Charge	V _{GE} = 15 V		16	22	nC
Q _{gc}	Gate-Collector Charge			50	65	nC

Electrical Characteristics of DIODE $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Unit
V_{FM}	Diode Forward Voltage	I _F = 15 A	$T_C = 25^{\circ}C$		1.7	2.7	٧
			T _C = 125°C		1.8		
t _{rr}	Diode Reverse Recovery Time	I _F = 15 A	$T_C = 25^{\circ}C$		210	330	ns
		$di_F/dt = 200 A/\mu s$	T _C = 125°C		280		
I _{rr}	Diode Peak Reverse Recovery Cur-		$T_C = 25^{\circ}C$		27	40	Α
	rent		T _C = 125°C		31		
Q _{rr}	Diode Reverse Recovery Charge		$T_C = 25^{\circ}C$		2835	6600	nC
			T _C = 125°C		4340		



www.onsemi.com

Typical Performance Characteristics

Figure 1. Typical Output Characteristics

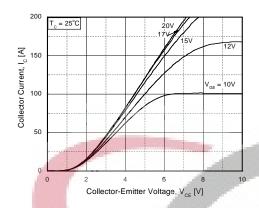


Figure 2. Typical Saturation Voltage Characteristics

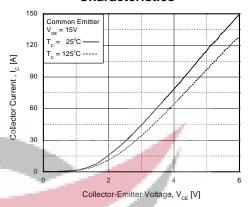


Figure 3. Saturation Voltage vs. Case
Temperature at Variant Current Level

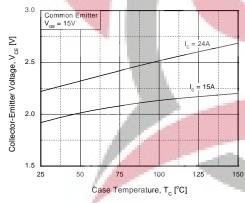


Figure 4. Saturation Voltage vs. V_{GE}

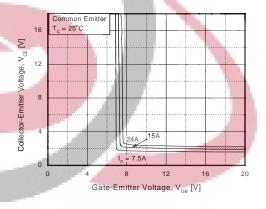


Figure 5. Saturation Voltage vs. V_{GE}

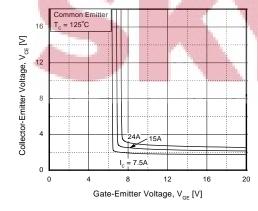
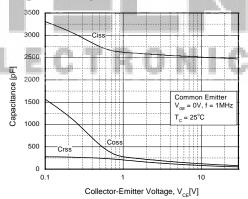


Figure 6. Capacitance Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Turn-On Characteristics vs. Gate Resistance

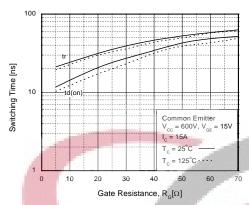


Figure 8. Turn-Off Characteristics vs. Gate Resistance

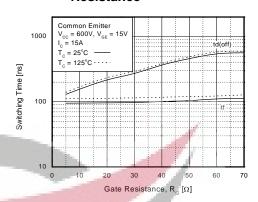


Figure 9. Switching Loss vs. Gate Resistance

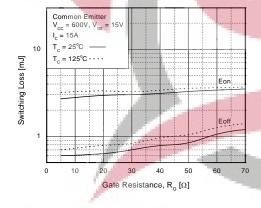


Figure 10. Turn-On Characteristics vs.
Collector Current

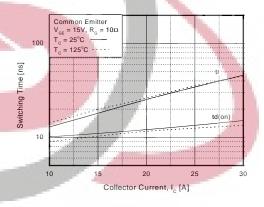


Figure 11. Turn-Off Characteristics vs.
Collector Current

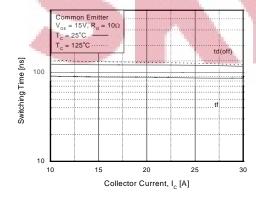
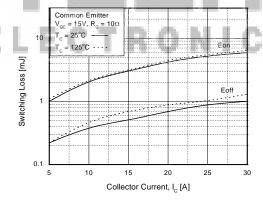


Figure 12. Switching Loss vs. Collector Current



Typical Performance Characteristics (Continued)

Figure 13. Gate Charge Characteristics

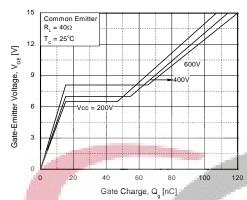


Figure 14. SOA Characteristics

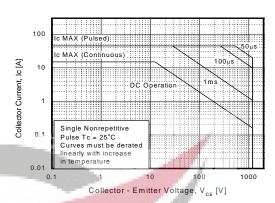


Figure 15. Turn-Off SOA

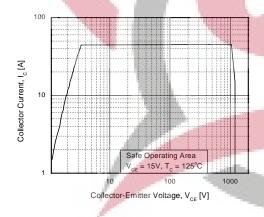
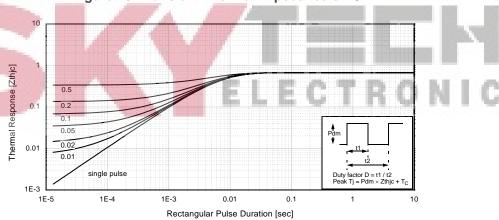


Figure 16. Transient Thermal Impedance of IGBT



Typical Performance Characteristics (Continued)

Figure 17. Forward Characteristics

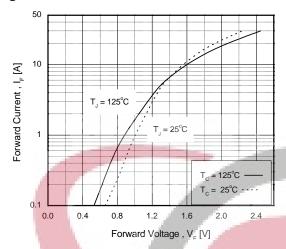


Figure 18. Reverse Recovery Current

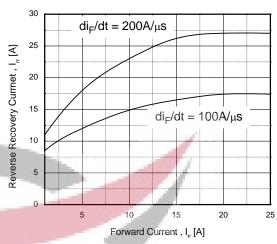


Figure 19. Stored Charge

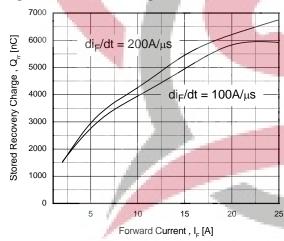
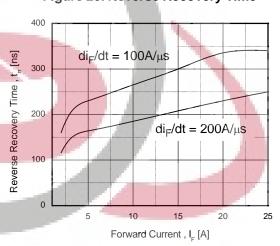


Figure 20. Reverse Recovery Time



SKITECH

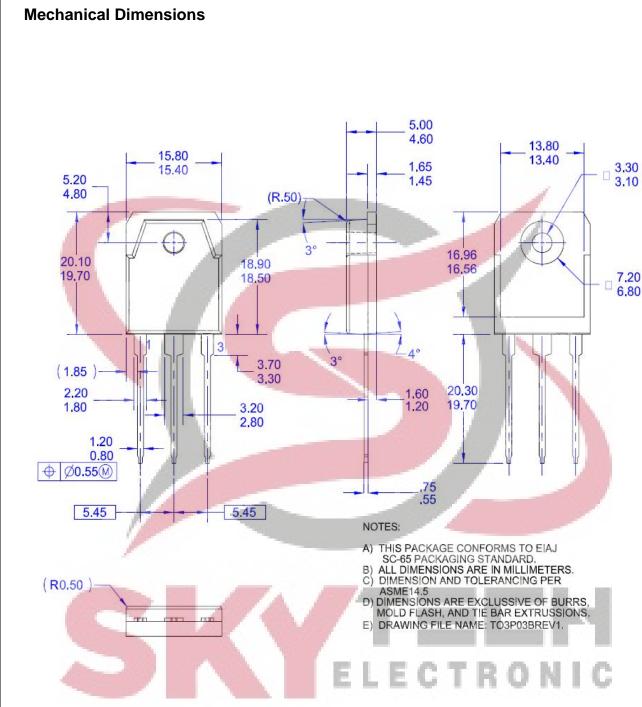


Figure 21. TO-3P 3L - 3LD, T03, PLASTIC, EIAJ SC-65

Package drawings are provided as a service to customers considering ON Semiconductor components. Drawings may change in any manner without notice. Please note the revision and/or date on the drawing and contact a ON Semiconductor representative to verify or obtain the most recent revision. Package specifications do not expand the terms of ON Semiconductor's worldwide terms and conditions, specif-ically the warranty therein, which covers ON Semiconductor products.



ON Semiconductor and in are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that ON Semiconductor was negligent regarding the design or manufacture of the part. ON Semiconductor is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910 Japan Customer Focus Center

Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative



Publi

Semiconductor Components Industries, LLC

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:



Published by WWW.\$KYTECH.ir